

**Search Notes**

Application/Control No.

10/769,047

Examiner

B. Chen

Applicant(s)/Patent under  
Reexamination

HERNER ET AL.

Art Unit

1762

**SEARCHED**

Class	Subclass	Date	Examiner
427	255.39 255.393	2/1/2006	BC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	2/1/2006	BC
discussed defective oath issue with SPE Meeks and QAS Gorgos	2/1/2006	BC